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## GaN transistors gate driving solutions

### Introduction

In switching-mode power supplies (SMPS), most topologies require at least a half-bridge to switch the voltage applied to an inductor or transformer. Ensuring isolation between the controller and the power switches is crucial for safe and reliable operation. We start by introducing the standard solution using pulse transformers, commonly used with traditional Si MOSFETs, and then explore various solutions based on gate drivers with different power supply implementations.

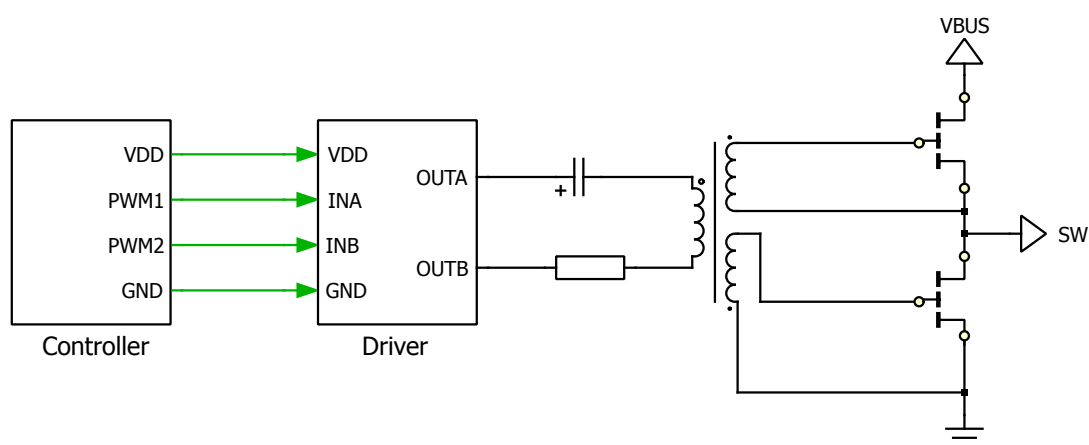
This application note aims to review key solutions for driving the gate of gallium nitride (GaN) devices to enhance robustness, power density, and overall efficiency. The comparison includes typical schematics along with PCB layout recommendations. Additionally, gate waveforms from a standard double pulse (DP) test are presented.



## 1 Pulse transformer (solution 1)

The pulse transformer is the most commonly used solution for driving a switch in a half-bridge leg. This well-known component is cost-effective and provides galvanic isolation. However, it requires a dual-channel driver to apply a positive voltage on the primary winding during the first half of the period and a negative voltage in the second half. Thanks to that, we insure that its core flux is well reset. By aware that some solutions with additional components around the pulse transformer exist to get a rid of this 50 % duty cycle limit.

Figure 1. Dual channel driver + pulse transformer



As mentioned in the introduction, this solution is typically used with MOSFETs. However, the fast  $dv/dt$  and  $di/dt$  characteristics of GaN technology expose the limitations of pulse transformers. The intrinsic pulse transformer leakage inductance combined with GaN fast switching can lead to oscillation on the gate and, at the end, potential shoot-through due to unexpected turn-on.

Moreover, the voltage-time area (E-T) imposes a minimum switching frequency. For example, when driving a GaN device with a  $\pm 6$  V swing (12 V total), a transformer with an E-T value of 80 V/ $\mu$ s would result in a minimum switching frequency of 75 kHz. Applications with lower frequencies would require a larger transformer with a higher E-T parameter.

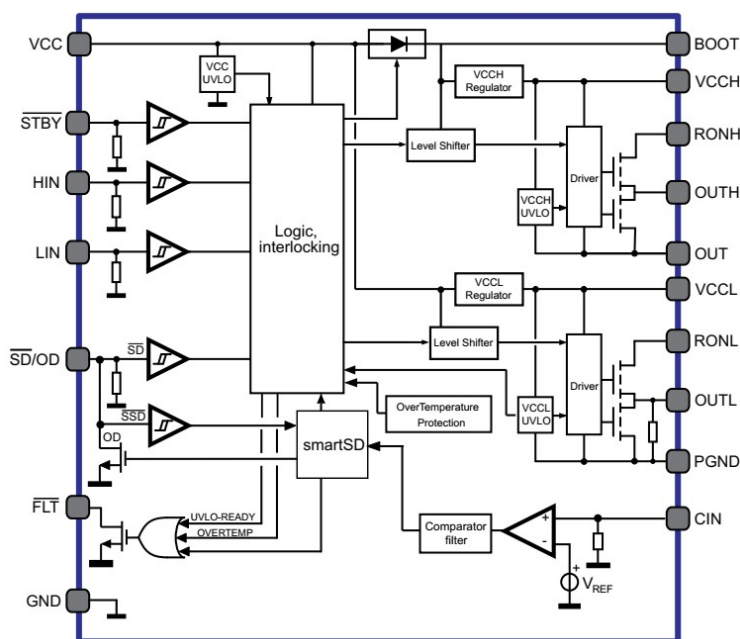
This configuration is not tested in this document due to the aforementioned limitations.

## 2 Driver with embedded bootstrap diode (solution 2)

The most challenging aspect of driving a half-bridge leg is managing the high-side switch. Since this component is floating and not referenced to the ground, a special implementation is necessary. The [STDRIVEG611](#) is one such solution (see [Figure 1](#)).

This device can drive both low and high-side switches in a compact QFN4x5x1 package. It is tailored for GaN technology, offering a lower UVLO threshold (compared to SiC or Si MOSFETs), high immunity to transient dv/dt ( $\pm 200$  V/ns), and the ability to achieve high switching frequencies ( $> 1$  MHz).

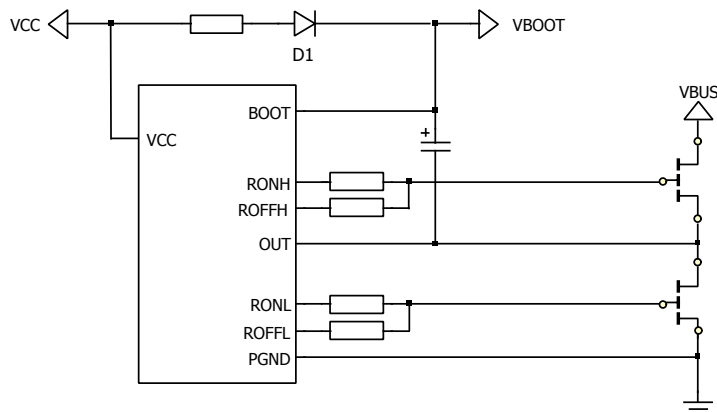
Figure 2. STDRIVEG611 block diagram



Let us discuss the power supply. As previously mentioned, driving the low-side switch is straightforward since its source terminal is referenced to the ground of the IC. However, the high-side switch is floating, and this driver includes an embedded bootstrap diode.

- **How does it work?:** You can refer to the [Figure 3](#), which shows the typical bootstrap network schematic.

Figure 3. Simplified bootstrap schematic for high side power supply



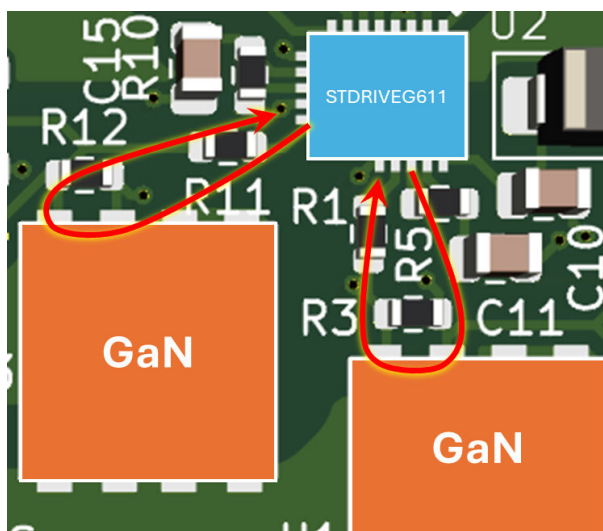
The bootstrap network primarily consists of a high voltage diode connected between the  $V_{CC}$  pin and the boot pin. Additionally, a capacitor is connected between the boot pin and the switching node, referred to as OUT for this IC. When the low-side switch is turned on, the OUT pin is brought to the same potential as the ground. During this phase, the bootstrap capacitor charges to the  $V_{CC}$  voltage level, minus the diode voltage drop.

Another key block of this driver is the  $V_{CC}$  regulator (Figure 2). This function ensures that the supply voltage for the high-side structure is well regulated to 6 V. Since the on-time duration varies depending on conditions such as line voltage and load, the time during which the capacitor needs to supply the high-side driver also varies. This is particularly relevant in PFC applications. Without a regulator, the voltage must be set below the maximum voltage accepted by the GaN device (7 V in our case). Considering some margin, 6 V is a good trade-off. In a TTPFC, the duty cycle can vary between 0 % and nearly 100 %, which could affect the bootstrap capacitor voltage. Having a regulator prevents supply voltage variations and ensures optimal GaN drive.

You can see the high side block is connected through a level shifter (with the noise immunity mentioned earlier) in order to sustain the high voltage offset.

Regarding the PCB layout, the small package size allows the driver to be placed as close as possible to the switches. The picture below shows a possible implementation with a PF8x8 bottom side cooling (BSC) package. The loop around the gate must be optimized to avoid ringing and unexpected shoot-through.

Figure 4. Gate drive layout example with STDRIVEG611

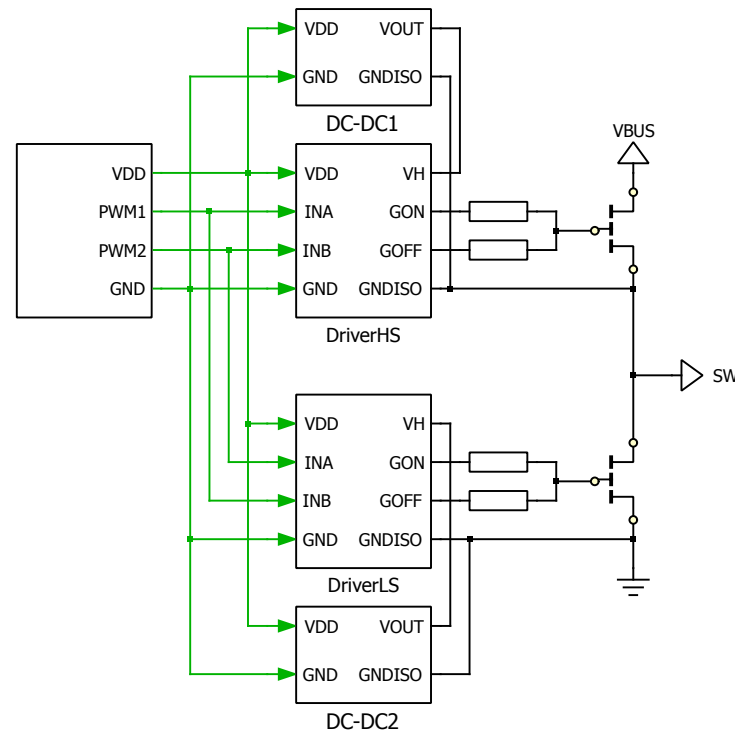


### 3 Single driver with embedded galvanic isolation and DC-DC power supply (solution 3)

To provide more flexibility for designers, two single drivers with embedded galvanic isolation can be used. During the design phase, physical constraints such as cooling systems (air or water cooling) or mechanical holes for attaching the PCB to the enclosure may arise. As a result, in a half-bridge configuration, both power switches might be positioned "far apart," even though the power loop should be minimized. Using single drivers allows the driving loop to be optimized with a short distance between the driver, gate resistance ( $R_{G(ON)}$  and  $R_{G(OFF)}$ ), and the gate pin itself. This approach offers significant flexibility for PCB layout, simplifying trace routing. It also facilitates parallelization, with one dedicated driver for all low- or high-side power switches.

In ST's product portfolio, the **STGAP2GS** is a single gate driver designed specifically for GaN technology. This component has separate sink and source pins to optimize turn-on and turn-off transitions, with high current capability for parallelization configurations (2 A source and 3 A sink).

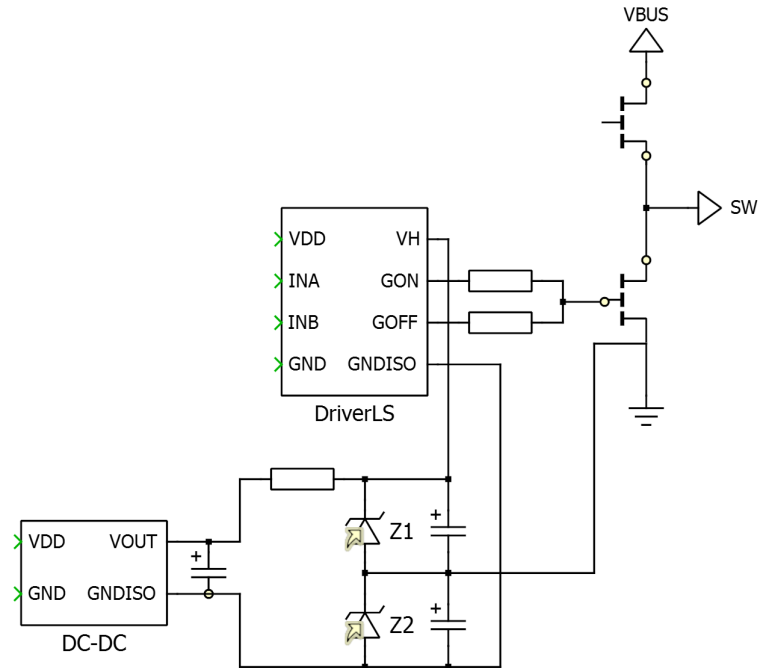
**Figure 5. Two single drivers with embedded galvanic isolation and isolated DC-DC**



In the schematic shown in [Figure 5](#), it is important to note that the secondary side of the driver requires an isolated power supply to maintain galvanic isolation. Several solutions can be used to generate the required voltage. One option is to use an isolated DC-DC module. Modules like the Murata NXJ family offer a variety of configurations for input and output voltages, ranging from 5 V to 12 V, with everything integrated.

To drive properly the GaN device, STMicroelectronics recommends supplying the gate with voltages between -3 V and +6 V. The on-state threshold ensures a full turn-on of the GaN device with sufficient margin below the maximum gate voltage limit of 7 V. The negative voltage is recommended to provide adequate margin between the off-state voltage and the  $V_{TH}$  threshold, which is lower for GaN compared to traditional Si MOSFETs. This negative voltage can be easily generated using simple Zener diodes, as illustrated in [Figure 6](#).

**Figure 6. Simple Zener diodes to generate a negative voltage**



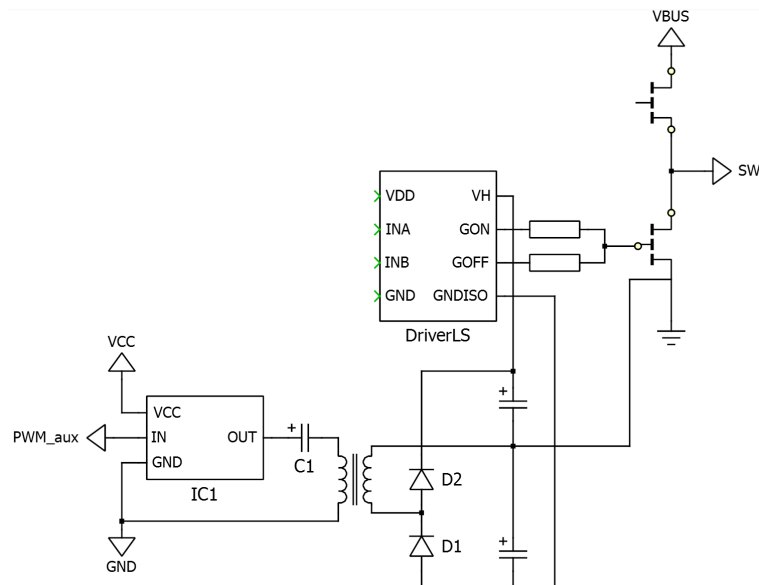
The output voltage is split into two parts to create a positive 6.2 V (using a 6.2 V Zener diode, Z1) and a negative 3 V (using a 3 V Zener diode, Z2). The series resistor sets the correct bias current to ensure a stable voltage. Typically, a 390  $\Omega$  resistor is sufficient for ST GaN devices.

The isolated Dc-Dc module is a convenient, ready-made solution, though it comes at a certain cost. An isolated power supply can also be created using a pulse transformer.

- **How does it work?:** The schematic is shown in [Figure 7](#)

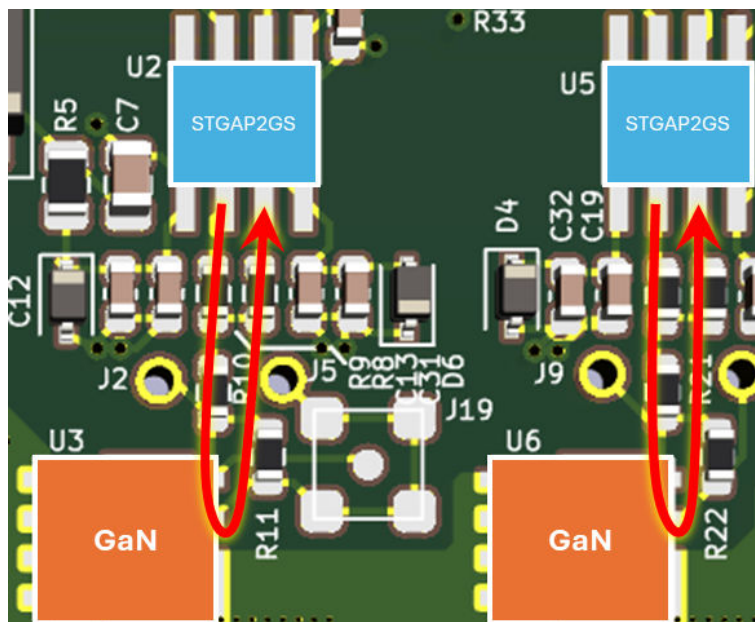
The transformer requires an AC signal on the primary winding. With the help of driver IC1, the 12-V DC voltage is converted to a -6 V/+6 V square wave signal, assisted by the PWM\_aux signal (for example, 90 kHz, 50 % duty cycle) and capacitor C1, which removes the DC component. The transformer, with a 1:1 turns ratio, delivers a -6 V/+6 V square wave signal. Finally, diodes D1 and D2 isolate the negative and positive voltages to supply the secondary side of the isolated driver [STGAP2GS](#).

**Figure 7. Alternative to the isolated DC-DC power supply**



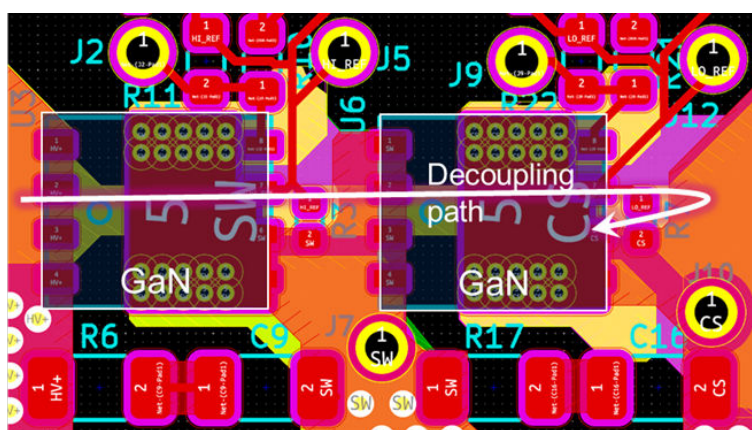
As mentioned earlier, having a dedicated driver for each GaN device provides substantial flexibility in PCB layout. [Figure 8](#) illustrates another possible layout implementation using the [STGAP2GS](#) driver, which is specifically designed for GaN devices.

**Figure 8. Gate loop layout example with STGAP2GS driver**



Each driver is placed as close as possible to the gate pin to optimize the driving loop for both devices. With this arrangement and the use of bottom-side cooling (BSC) packages (PF8x8 or PF5x6), both devices can be positioned side by side. Since PowerGaN transistors are used for high power and copper zones are typically used to conduct the current, the flux cancellation principle must be applied to reduce parasitic inductance. When two planes are face-to-face and conduct equal but opposite currents, the fluxes created by the currents cancel each other, effectively eliminating inductance. As illustrated in [Figure 9](#), using the first inner layer as a power loop return path, just below the top layer, allows for a small loop size and reduced parasitic inductance due to field self-cancellation.

**Figure 9. Power loop layout example using GaN PF5x6 package**



This layout example, with a BSC cooling package and a single isolated driver, provides the optimal combination for enhancing both the drive and power loops.

## 4 Comparison

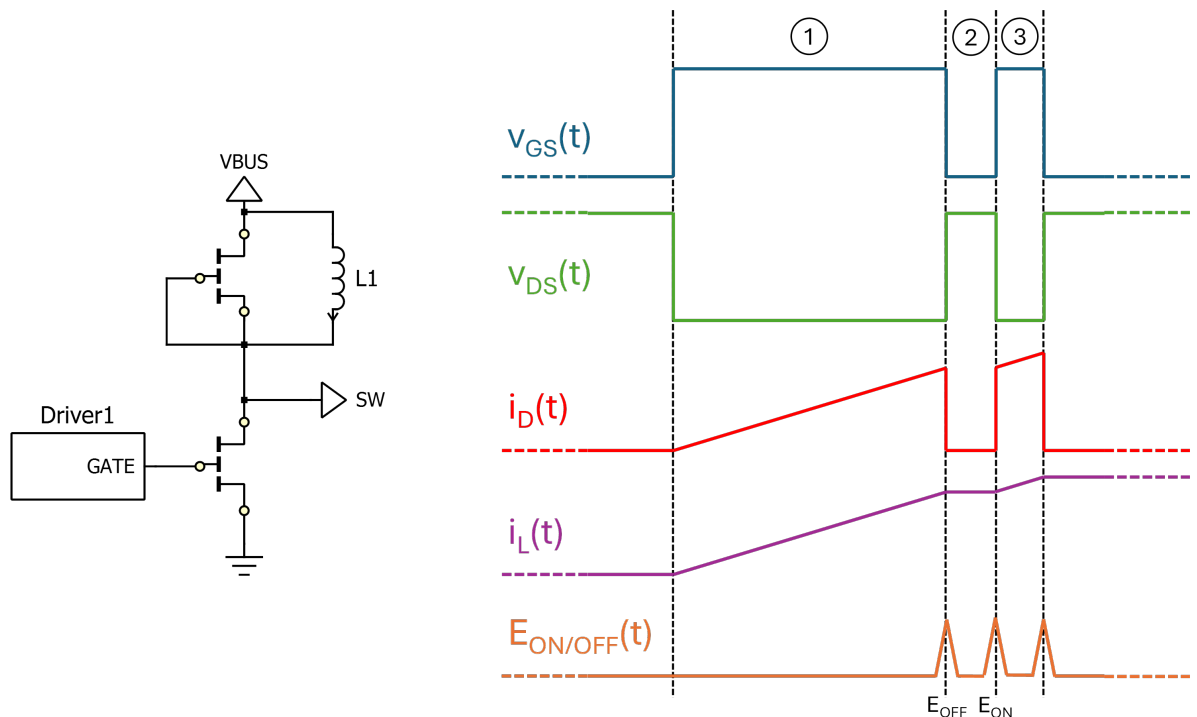
- What do the waveforms look like for the solutions presented above?
- Why not use the double pulse (DP) test method?

The double pulse test is a widely used technique for characterizing the switching behavior of power semiconductor devices such as MOSFETs, IGBTs, SiC, and GaN transistors. This test is essential for understanding the dynamic performance, switching losses, and efficiency of these devices in power electronic circuits.

The test procedure can be divided into three main phases (Figure 10):

1. Initially, the first pulse is generated by turning on the low-side device. Current begins to flow through the device and the load inductor, ramping up to a specified value where all parameters need to be extract
2. During the next step, the gate driver turns off the device for a short period. The current freewheels through the freewheeling diode (if present) or the high-side device (reverse conduction mode)
3. Finally, the gate driver sends a second pulse to turn the device back on. The current ramps up again, and the device is then turned off again

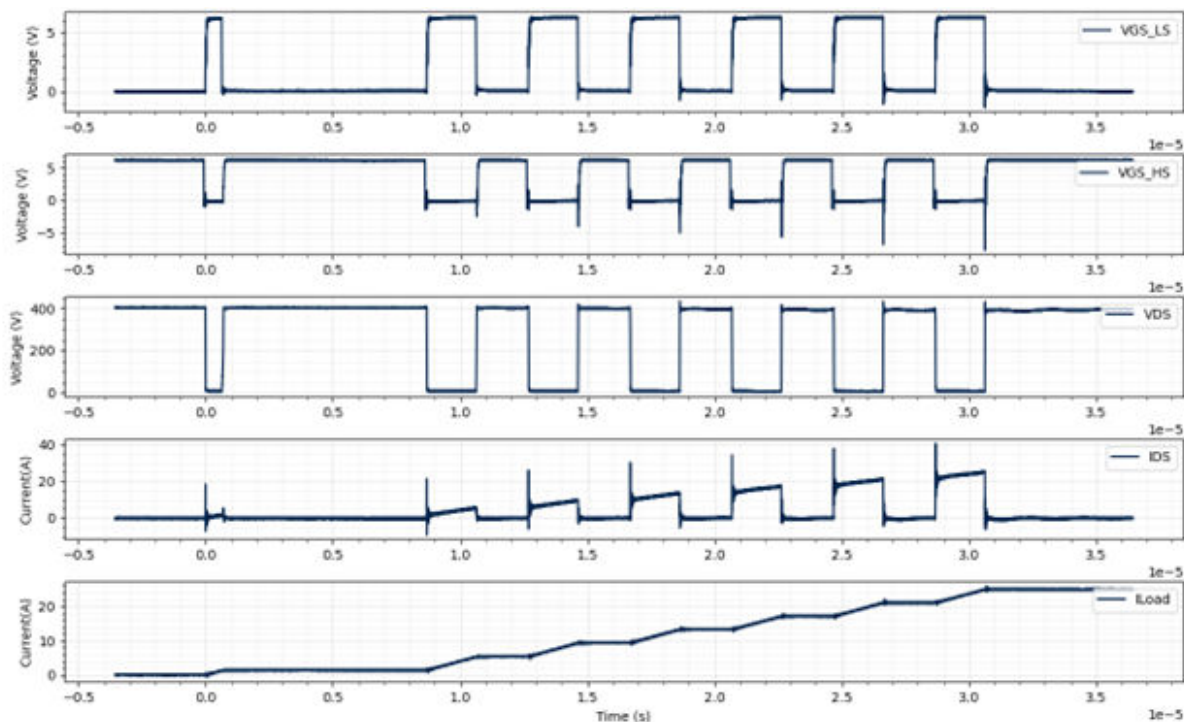
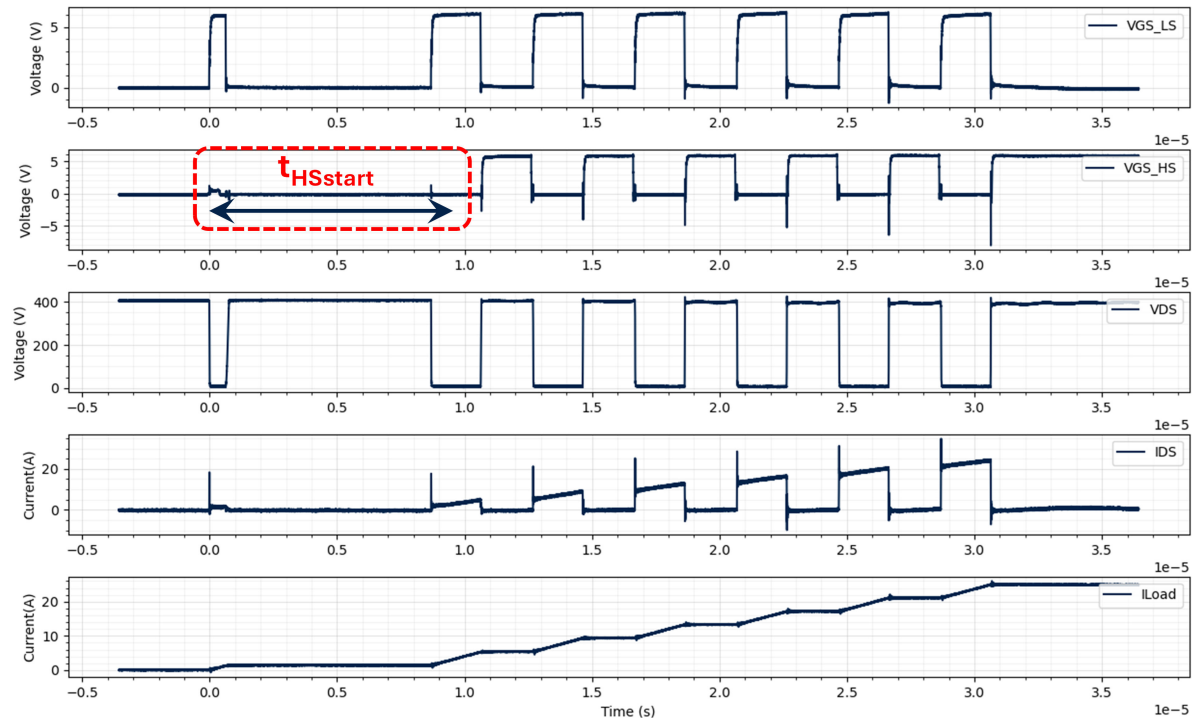
**Figure 10. Typical double pulse setup and simplified waveforms**



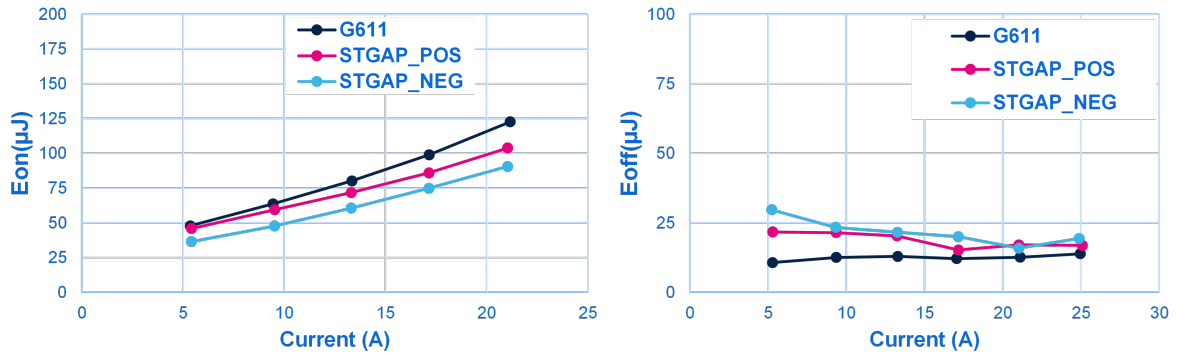
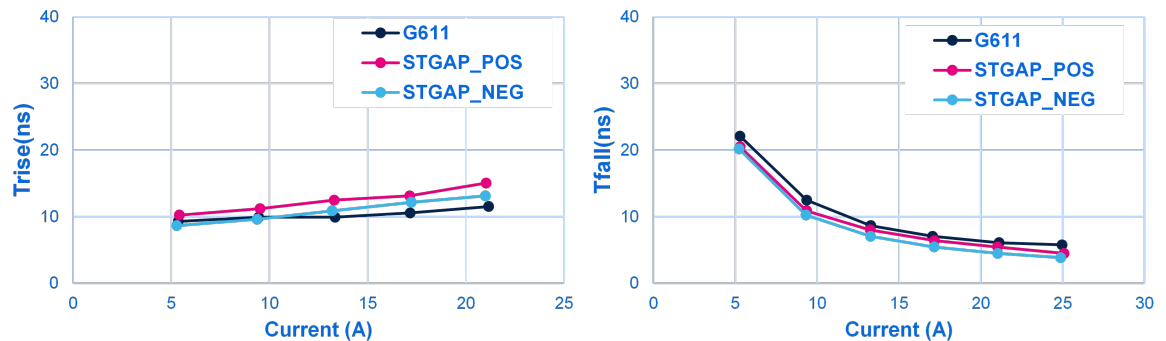
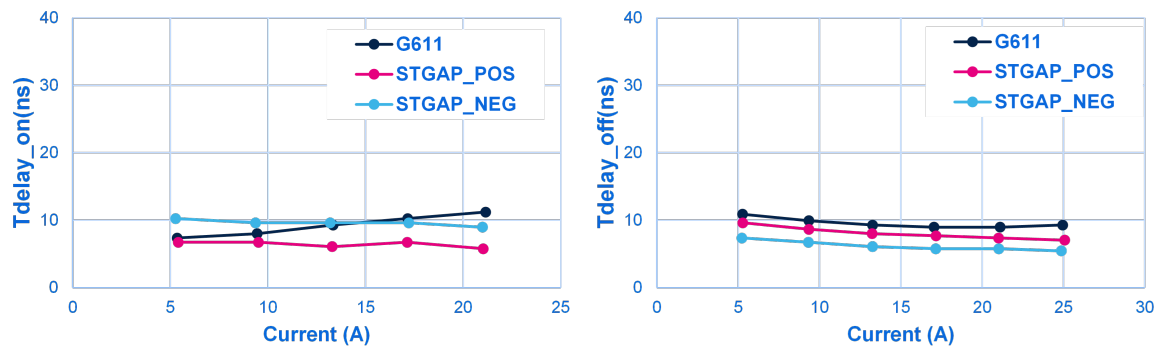
This sequence allows the extraction of all necessary information about the GaN devices, including switching times (rise time, fall time, delay times) and switching losses (energy loss during turn-on and turn off). In the following waveforms, we customized the double pulse test to a multipulse test to extract all parameters at different current levels, while avoiding self-heating of the die.

Let us compare the DP results among three different drive methods:

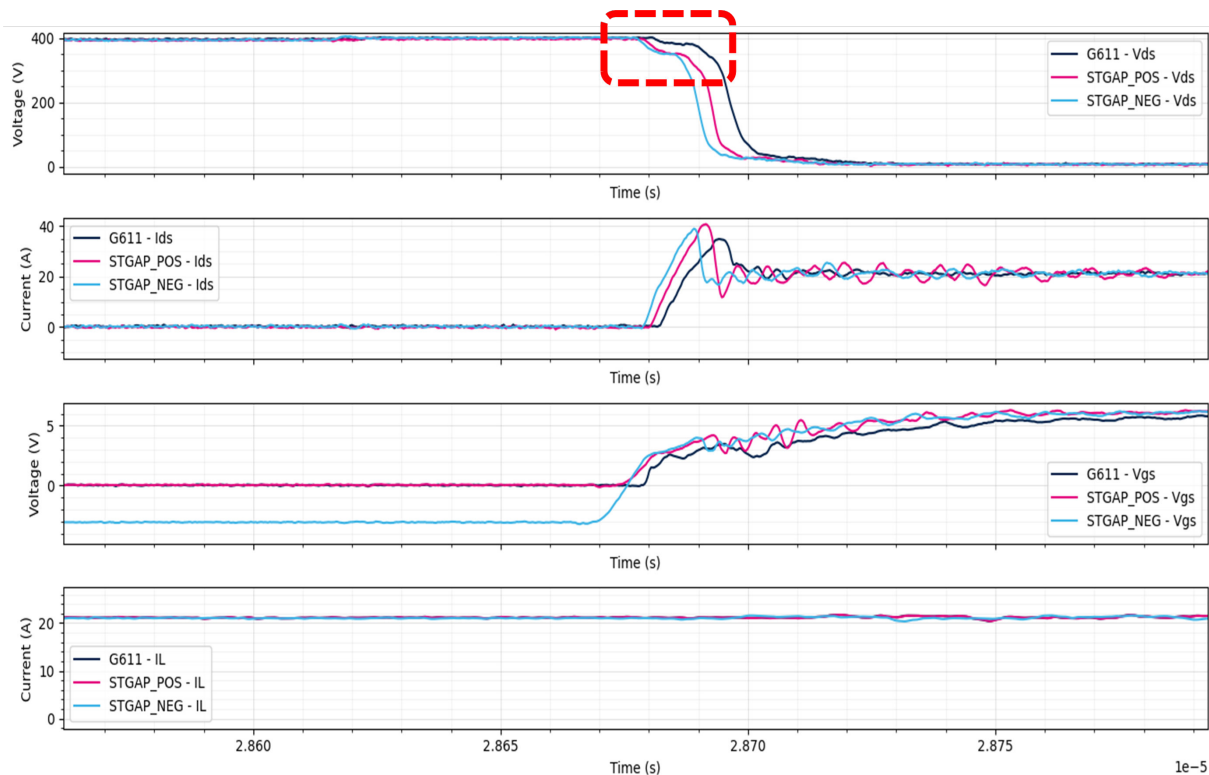
1. STGAP2GS with gate voltage between 0 V and +6.2 V - Figure 11
2. STGAP2GS with gate voltage between -3 V and +6.2 V
3. STDRIVEG611 with gate voltage between 0 V and + 6 V - Figure 12

**Figure 11. Multipulse with STGAP2GS - Positive voltage only**

**Figure 12. Multipulse with STDRIVEG611**


One other particularity in the above procedure is related to the two first pulses. In the **STDRIVEG611**, a  $t_{HSstart}$  timer (5  $\mu s$  max) is implemented before accepting HS PWM signals to allow sufficient time for the bootstrap capacitor to be fully charged. To limit the effect of this particularity, a short pulse with a long off time is generated before producing the second pulse. In this case, only the first pulse operates asynchronously for the high-side switch. The same sequence has been applied to the **STGAP2GS** for a fair comparison.

**Figure 13. Switching losses  $E_{ON}$  and  $E_{OFF}$** 

**Figure 14. Rise and falling time**

**Figure 15. Delay time**


From the above waveforms, all extracted parameters are very close to each other. At high current levels, we can notice a difference in the  $E_{ON}$  curve. A zoom-in has been done in to understand the reason.

**Figure 16.  $E_{on}$  extraction at 21 A**


With the **STDRIVEG611** board, the plateau on the drain-to-source voltage during turn-on is larger and deeper compared to the **STGAP2GS** daughter board. This plateau is directly linked to the power loop and the corresponding parasitic inductance.

According to **Figure 16**, the parasitic inductance can be evaluated at 10 nH for the **STGAP2GS** daughter board and only 5.7 nH for the **STDRIVEG611**. We can also notice that the gate voltage is faster with the **STGAP2GS**.

Indeed, this isolated driver is stronger than the nonisolated one. The combination of these two elements leads to this difference.

## Appendix A References

**Table 1.** reference name and description

Ref. name	Document name	Document links
[1]	Galvanically isolated 3 A single gate driver for Enhancement mode GaN FETs	<a href="#">STGAP2GS</a>
[2]	High voltage and high-speed half-bridge gate driver for GaN power switches	<a href="#">STDRIVEG611</a>
[3]	Evaluation board for STDRIVEG611 600 V high-speed half-bridge gate driver with SGT120R65AL e-mode GaN HEMT	<a href="#">EVLSTDRIVEG611</a>
[4]	Demonstration board for STGAP2GS galvanically isolated single gate driver with e-mode GaN transistor	<a href="#">EVSTGAP2GS</a>

## Revision history

**Table 2. Document revision history**

Date	Revision	Changes
28-Feb-2025	1	Initial release.

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